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Capacitance of Graphene Bilayer as a Which-Layer Probe

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The unique capabilities of capacitance measurements in bilayer graphene enable probing of layer-specific properties that are normally out of reach in transport measurements. Furthermore, capacitance measurements in the top-gate and penetration field geometries are sensitive to different physical quantities: the penetration field capacitance probes the two layers equally, whereas the top gate capacitance preferentially samples the near layer, resulting in the “near-layer capacitance enhancement” effect observed in recent top-gate capacitance measurements. We present a detailed theoretical description of this effect and show that capacitance can be used to determine the equilibrium layer polarization, a potentially useful tool in the study of broken symmetry states in graphene. Moreover, whereas electrical transport is often dominated by a small subset of electronic states, capacitance probes all states equally. Consequently, capacitance is a useful tool in the study of phenomena in which localization plays a role, such as quantum Hall effects and the metal-insulator transition. Under certain conditions, the quantum capacitance can become an order-one effect.

Graphene and its bilayer are ideal materials for the application of the capacitance technique. The two-dimensional geometry of these materials permits the placement of proximal metal gates, electrolytic solutions, or scanning probe heads, all of which can be used to probe capacitance. Interesting results have been obtained for monolayer graphene, in which this quantum capacitance was found to dominate the total capacitance near the Dirac point even at room temperature. Surprisingly, the compressibility measured at low temperature was found to be well described by the noninteracting massless Dirac model, a fact attributed to an exact cancelation of correlation effects in the monolayer. In bilayer graphene (BLG), in contrast, the interaction effects are expected to be strong, potentially leading to novel many-body states near charge neutrality. Such effects, if they exist, would directly manifest themselves in compressibility measurements.

In this paper we discuss the unique capabilities of capacitance measurements in BLG. Due to the finite interlayer separation, capacitance measurements can probe layer-specific properties that are out of reach in conventional transport measurements in which the layers are not contacted separately. Motivated by recent experiments, we calculate the effect of a gate-induced charge imbalance between the layers on the measured capacitance in several geometries, taking into account electronic interactions and short range disorder. We interpret the peculiar electron-hole asymmetry observed in top-gate capacitance measurements in terms of a “near-layer capacitance enhancement”, which is a combined effect of van Hove singularities in the BLG band structure and the interlayer screening. We show that capacitance experiments can be used as a which-layer probe, offering a unique capability in studying electronic properties of graphene.

I. INTRODUCTION

Capacitance measurements probe the energy cost of moving charge between different parts of a system. In a classical system, this energy cost is a purely geometric quantity and consists of the electrostatic energy. In contrast, capacitance measurements performed on quantum systems can access a range of subtle and interesting phenomena. In particular, Pauli exclusion in degenerate electronic systems gives rise to a characteristic quantum contribution to the internal energy. The associated contribution to capacitance, known as ‘quantum capacitance’, is proportional to the electronic compressibility. In addition, at low carrier densities, the internal energy is dominated by electronic correlations, resulting in a so-called negative compressibility contribution to capacitance. In low dimensional systems these effects can amount to a sizeable contribution, making capacitance measurements a powerful probe of many-body effects. Moreover, whereas electrical transport is often dominated by a small subset of electronic states, capacitance probes all states equally. Consequently, capacitance is a useful tool in the study of phenomena in which localization plays a role, such as quantum Hall effects and the metal-insulator transition.

Under certain conditions, the quantum capacitance can become an order-one effect. Graphene and its bilayer are ideal materials for the application of the capacitance technique. The two-dimensional geometry of these materials permits the placement of proximal metal gates, electrolytic solutions, or scanning probe heads, all of which can be used to probe capacitance. Interesting results have been obtained for monolayer graphene, in which this quantum capacitance was found to dominate the total capacitance near the Dirac point even at room temperature. Surprisingly, the compressibility measured at low temperature was found to be well described by the noninteracting massless Dirac model, a fact attributed to an exact cancelation of correlation effects in the monolayer.

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In this paper we discuss the unique capabilities of capacitance measurements in BLG. Due to the finite interlayer separation, capacitance measurements can probe layer-specific properties that are out of reach in conventional transport measurements in which the layers are not contacted separately. Motivated by recent experiments, we calculate the effect of a gate-induced charge imbalance between the layers on the measured capacitance in several geometries, taking into account electronic interactions and short range disorder. We interpret the peculiar electron-hole asymmetry observed in top-gate capacitance measurements in terms of a “near-layer capacitance enhancement”, which is a combined effect of van Hove singularities in the BLG band structure and the interlayer screening. We show that capacitance experiments can be used as a which-layer probe, offering a unique capability in studying electronic properties of graphene.

II. THE NEAR-LAYER CAPACITANCE ENHANCEMENT

Recently, capacitance techniques have been applied to dual-gated bilayer graphene. The geometry of these devices allows the electrostatic potentials on the two layers to be varied independently, enabling independent control of both carrier density and the gap in the electronic spectrum. In the absence of external fields, BLG...
is a metal characterized (at sufficiently low energies) by approximately parabolic valence and conduction bands which touch at the corners of the hexagonal Brillouin zone (at the K and K’ points). The degeneracy at this band crossing is protected by the symmetry of the BLG crystal structure, in which atomic sites on different layers are equivalent under transformations of the point symmetry group. Application of an external electric field perpendicular to the layers breaks the which-layer symmetry, turning BLG into a semiconductor with a gate-tunable band gap. At not too strong fields the gapped state can be described\textsuperscript{27} by projecting the tight binding Hamiltonian on the low-energy subspace of wavefunctions ($\psi_1$, $\psi_2$) where the subscript indicates the layer index, giving the two-band Hamiltonian

$$H_0(p) = \left( \begin{array}{cc} \frac{1}{2} & \frac{p_1}{2m} \\ \frac{p_1}{2m} & \frac{1}{2} \end{array} \right) \frac{v_1^2}{v_2^2}, \quad p_\pm = p_x \pm ip_y,$$

where momentum $p$ is measured relative to the K (or $K'$) point and $v_1$, $v_2$ are the potentials on each layer, controlled by external gates or dopants. The Hamiltonian (1) features a band gap of size $\Delta = |v_1 - v_2|$, and a pair of van Hove singularities (vHS) in the density of states of inverse square root form positioned on either side of the gap at $\varepsilon = v_1$ and $\varepsilon = v_2$. The field-induced gapped state is characterized by interlayer density imbalance, in which the occupancies of the two layers are very different for $v_1 = v_2$ and for $v_1 \neq v_2$. For the balanced bilayer ($v_1 = v_2$) the wavefunction amplitudes on each layer are equal (up to a phase); however, in the presence of an imbalance ($v_1 \neq v_2$) the amplitudes become unequal. This leads to population imbalance between the two layers,

$$|\psi_{1(2)}(p)|^2 = \frac{1}{2} \left[ 1 \pm \frac{1}{2} \frac{v_1 - v_2}{(p^2/m)^2 + (v_1 - v_2)^2} \right],$$

with a higher occupancy on the layer which has lower energy. This layer population asymmetry results in a strong asymmetry in the partial (layer specific) densities of states: since each vHS shows up only in the partial density of states for one of the two layers, the corresponding divergent contribution to compressibility comes only from the vHS-bearing layer, remaining finite for the other layer.

As we discuss in detail below, the layer population asymmetry, Eq.(2), manifests itself in capacitance measurements. This is illustrated in Fig.1(b), in which top-gate capacitance found using a self-consistent model (see Sec.IV) is plotted as a function of gate voltages $V_1$ and $V_b$. The enhancement in capacitance associated with the band edge is stronger when the divergent vHS-bearing layer is facing the gate used to measure capacitance (top layer for $C_b$ and bottom layer for $C_b$ in Fig. 1 a). We refer to this behavior as ‘near-layer capacitance enhancement’ (NLCE). This NLCE effect is seen in the capacitance map shown in Fig.1(b): the dark region, corresponds to the insulating state realized when the chemical potential is positioned inside field-induced gap, is bordered on one side by a bright fringe corresponding to the NLCE. The markedly different contrast between the van Hove singularity-associated features positioned on either side of the dark region, is associated with the density piling up on the near layer rather than the far one.

This behavior explains the asymmetry observed in top-gate capacitance measurements\textsuperscript{12}, in which a feature identified with the vHS was observed only for electrons (holes) when the high (low) energy layer was nearest the gate from which capacitance was measured. In contrast, no such asymmetry is expected for the capacitance measured using ‘penetration field’ geometry\textsuperscript{11}, because the penetration field capacitance is more symmetric than the one-sided (top or bottom) gate capacitance. Indeed, no NLCE-type asymmetry was observed in the measurements reported in Ref.\textsuperscript{11}. As we shall see, the gate capacitance and the penetration field capacitance measure fundamentally different characteristics of the system. Simultaneous measurements of gate and penetration field capacitances can thus provide detailed and direct information on layer polarization of the bilayer.

The NLCE effect is sensitive to the form of the vHS, which depends on the specifics of the dispersion relation. The simplest model for BLG, which we focus on below, is that of quartic dispersion, described by the Hamiltonian (1). A more detailed analysis\textsuperscript{27–29}, based on the four band model, leads to a ‘Mexican hat’ structure in band dispersion near points K and K'. However, the Mexican hat dispersion and the quartic dispersion both lead to an inverse square-root vHS at the band edge, resulting in essentially identical NLCE effects.

In this paper we develop theory of the NLCE effect. In section III we calculate, using a two band model of BLG, layer-indexed densities of states, $\nu_{ij} = -\partial n_i/\partial v_j$, where $i, j = 1, 2$ refer to the two layers. In section IV we develop a many-body approach that describes interactions of particles in BLG with other particles and also with gate potentials. Using a self-consistent Hartree-type approximation, we derive expressions for several quantities of interest relevant to capacitance measurements in terms of the matrix elements $\nu_{ij}$. We find that different experimental observables exhibit very different behavior. In particular, the gate capacitance exhibits strong particle-hole asymmetry and the NLCE effect (see Fig.1), while the penetration-field capacitance is nearly particle-hole symmetric. In section V, we consider the effect of disorder, and show that the asymmetry persists for relatively high disorder concentrations corresponding to the experimental regime. Finally, we conclude with a discussion of the usefulness of different capacitance measurements in bilayer graphene for probing the layer-pseudospin texture of possible broken symmetry phases.
The enhancement of an AC driving potential on one of the gates. b) Top gate capacitance as a function of external gate potentials for a clean bilayer, calculated using the self-consistent approach over four flavors $\alpha$ where $H = 1 \int_0^\infty \delta(V - \mu)$. The enhancement is asymmetric, reflecting the asymmetric population of the layers, Eq.(2).

III. THE VAN HOVE SINGULARITIES AND COMPRESSIBILITY IN CLEAN BLG

The main features of the compressibility of BLG in an external field can be understood in terms of the many-body Hamiltonian

$$H = \sum_{p,\alpha} \psi_{i,\alpha}^\dagger H_0 \psi_{i,\alpha} + H_{\text{int}}$$

where $H_0$ is the single-particle Hamiltonian (1) and summation over four flavors $\alpha = 1, 2, 3, 4$ accounts for the spin and valley ($K, K'$) degrees of freedom. The interaction is written in terms of density harmonics on the layers, $n_{i,k} = \sum_{p,\alpha} \psi_{i,p,\alpha}^\dagger \psi_{i,p+k}$ ($i = 1, 2$),

$$H_{\text{int}} = \frac{1}{2} \sum_k \left( \begin{array}{c} n_{1,-k} \\ n_{2,-k} \end{array} \right)^T \left( \begin{array}{cc} V_k & \tilde{V}_k \\ \tilde{V}_k & V_k \end{array} \right) \left( \begin{array}{c} n_{1,k} \\ n_{2,k} \end{array} \right),$$

with $V_k$ and $\tilde{V}_k$ the intralayer and interlayer Coulomb interaction,

$$V_k = 2\pi e^2 / |k| d V_k = e^{-|k|d} V_k,$$

where $d \approx 0.3$ nm is the interlayer spacing in BLG.

We analyze quantum corrections to the capacitance of gated BLG described by the Hamiltonian (3) using a Hartree-type approximation. This is done in two steps. We first find the compressibility matrix of non-interacting fermions, formally setting $H_{\text{int}} = 0$ in Eq.(3). In doing this, the BLG potentials $v_1$ and $v_2$ are treated as external parameters. Next, in Sec.IV, we restore the interaction $H_{\text{int}}$, adding to it the interaction between all charges, including those on the gates. We relate potentials $v_1(2)$ to charges on the gates and the graphene bilayer self-consistently, and use these relations to evaluate capacitance as a function of external gate voltages.

The Hartree-type analysis presented in this paper does not account for correlation effects; however, estimates of the correlation energy and the analysis of compressibility of BLG presented in Ref.[25] indicate that the corresponding correction to capacitance is small, except at very low values of disorder and temperature, where the BLG system develops an instability towards a correlated state.

In recent experiments$^{11,12}$ electronic states with different doping relative to the neutrality point are probed by varying the potentials $v_1$ and $v_2$ through their response to the potentials $v_1$ and $v_2$ applied to external gates. Metallic and insulating conductance regimes occur when the Fermi level lies inside or outside the gate-induced gap$^{30-32}$. The insulating regime was observed to accompany a drop in compressibility.

It is convenient to introduce layer-symmetrized potentials $v_{\pm} = \frac{1}{2}(v_1 \pm v_2)$. Within the two band model (1), the gap size is $\Delta = 2|v_-|$ and the position of the gap center relative to the Fermi level is $v_+ - \mu$; the metallic and insulating regimes in a clean bilayer are then described by $|v_+ - \mu| > |v_-|$ and $|v_+ - \mu| < |v_-|$, respectively. In experiments$^{11,12}$ capacitance was measured with the graphene bilayer grounded. This situation can be described by a Fermi level pinned to zero energy, $\mu = 0$.

Particle densities on the two layers can be expressed as sums over all occupied states,

$$n_{1(2)} = \int \frac{d^2p}{(2\pi \hbar)^2} f(p) |\psi_{1(2)}(p)|^2,$$

where $f(p) = 1/(e^{p/\beta} + 1)$. In what follows, we focus on the case of zero temperature, $f(p) = \theta(-\varepsilon(p))$. Using the eigenstates of the Hamiltonian (1) and defining layersymmetrized densities $n_{\pm} = n_1 \pm n_2$, we find

$$n_+ = \left\{ \begin{array}{ll} -v_0 \sqrt{v_+^2 - v_-^2} \text{sgn} v_+ & \text{(metal)}, \\ 0 & \text{(insulator)}, \end{array} \right.$$

$$n_- = \left\{ \begin{array}{ll} -v_0 v_- \ln \left( \frac{\Lambda}{v_+ + v_-} \right) & \text{(metal)}, \\ -v_0 v_- \ln \left( \frac{2\Lambda}{v_+ - v_-} \right) & \text{(insulator)}, \end{array} \right.$$

where $\Lambda$ is an ultraviolet cutoff of order the bandwidth. Here $v_0 = 2me^2/(\pi\hbar^2)$ accounts for the four-fold spin/valley degeneracy, and can be written as $2/\pi a_B$, where $a_B$ is the Bohr’s radius of BLG. The two cases in Eqs.(7),(8), metallic and insulating, correspond to the regimes $|v_+| > |v_-|$ and $|v_+| < |v_-|$.

Using these expressions we can compute the entries of the compressibility matrix $\kappa_{ij} = -\partial n_i/\partial v_j$. The expressions have different form for $|v_+| > |v_-|$ and for
where we defined

\[
\begin{align*}
\nu_{++} &= \left\{ \begin{array}{ll}
\frac{\nu_0}{\sqrt{\nu_+^2 - \nu_-^2}} & \text{(metal),} \\
0 & \text{(insulator),}
\end{array} \right. \\
\nu_{--} &= \left\{ \begin{array}{ll}
\tilde{\nu}_0 + \nu_0 & \text{(metal),} \\
\nu_0 & \text{(insulator),}
\end{array} \right. \\
\nu_{+-} &= \nu_{-+} = \left\{ \begin{array}{ll}
-\nu_0 & \text{(metal),} \\
0 & \text{(insulator),}
\end{array} \right.
\end{align*}
\]

where we defined

\[\tilde{\nu}_0 = \nu_0 \ln \left( \frac{2\Lambda}{e(\nu_+^2 + \sqrt{\nu_+^2 - \nu_-^2})} \right),\]

with \(e = 2.71828\ldots\). Expressions (9)-(11) are plotted in the left panel of Fig. 2. Note that the compressibility matrix is symmetric, \(\nu_{+-} = \nu_{-+}\).

Different elements of matrix \(\tilde{\nu}\) have different physical meanings. The diagonal element \(\nu_{++} = -\partial n_+ / \partial \nu_+\) is the total charge compressibility. The diagonal element \(\nu_{--} = -\partial n_- / \partial \nu_-\) is layer polarizability. The off-diagonal elements \(\nu_{-+} = \nu_{+--}\) describe the charge-flavor response. The latter quantities are particularly useful, as they measure the layer distribution of incremental additions of charge, giving information about the layer polarization of the ground state: the quantities \(\nu_{-+}\) and \(\nu_{+-}\) are zero for an unpolarized bilayer, but nonzero in the presence of a charge imbalance.

Rewriting Eqs. (7), (8) in terms of variables characterizing individual layers, \(n_1, n_2\), we obtain

\[
\begin{align*}
\nu_{11} &= \frac{1}{2} \nu_0 \left| \frac{\nu_+ - \nu_- \text{sgn} \nu_+}{\sqrt{\nu_+^2 - \nu_-^2}} \right| + \frac{1}{4} \tilde{\nu}_0, \\
\nu_{22} &= \frac{1}{2} \nu_0 \left| \frac{\nu_+ + \nu_- \text{sgn} \nu_+}{\sqrt{\nu_+^2 - \nu_-^2}} \right| + \frac{1}{4} \tilde{\nu}_0, \\
\nu_{12} &= \nu_{21} = -\frac{1}{4} \tilde{\nu}_0.
\end{align*}
\]

Expressions (13)-(15) are invariant under simultaneous 1 ↔ 2 exchange and gap inversion, \(\nu_- \rightarrow -\nu_+\).

Both of the diagonal compressibility matrix elements \((\nu_{11} \text{ and } \nu_{22})\) exhibit an inverse square root divergence at the charge gap edge, where the density of single particle states has a van Hove singularity. The two diagonal compressibilities behave asymmetrically, diverging on opposite sides of the gap: \(\partial n_1 / \partial \nu_1\) diverges at \(\nu_1 \rightarrow 0\), while \(\partial n_2 / \partial \nu_2\) diverges at \(\nu_2 \rightarrow 0\). In contrast, the off-diagonal compressibilities \((i \neq j)\) remain finite on either side of the charge gap and are symmetric (see Fig. 2, left panel). Inside the charge gap, \(|\nu_+| < |\nu_-|\), the diagonal and off-diagonal compressibilities are constant:

\[
\nu_{11} = \nu_{22} = -\nu_{12} = -\nu_{21} = \frac{\nu_0}{4} \ln \left( \frac{2\Lambda}{e|\nu_-|} \right).
\]

FIG. 2: Energy dependence of the interlayer compressibility matrix elements \(\nu_{ij}\) in the 1/2 (left panel, Eqs. (13)-(15)) and \(\nu_{\pm}\) (right panel, Eqs. (9)-(11)) bases for fixed interlayer asymmetry \(\nu_- = 50\text{meV}\) and \(\Delta = 5\text{eV}\). In the left panel, single layer charge compressibilities \(\nu_{11}\) and \(\nu_{22}\) are divergent only on one side of the charge gap, allowing the interlayer asymmetry to be probed by single side capacitance measurements. In the +/− basis, this asymmetry is reflected by the charge-flavor response, \(\nu_{\pm}\), exhibiting no divergence at the gap edge.

IV. SELF-CONSISTENT CAPACITANCE CALCULATION

We shall focus on the geometry pictured in Fig. 1a, which describes a dual-gated graphene device of the type studied in Refs. [12] and [11]. The experimental system consists of a bilayer graphene sheet placed between two gates, characterized by potentials \(v_1\) and \(v_2\), charge densities \(n_1\) and \(n_2\), and geometric capacitances to the bilayer \(C_{01}^0\) and \(C_{02}^0\). The bilayer is described by the potentials \(v_1\) and \(v_2\) and charge densities \(n_1\) and \(n_2\) induced by the external gates on the individual layers. Electrostatic energy of the bilayer itself is taken into account by including an interlayer capacitance \(C_{\text{BLG}}\), which can be estimated from the “geometric” value obtained for a parallel plate capacitor, \(C_{\text{BLG}} = (4\pi d)^{-1},\) with \(d \approx 0.3\text{nm}\). This electrostatic model amounts to the approximation that the charge density on the bilayer is of the form \(n(z) = n_1 \delta(z - d/2) + n_2 \delta(z + d/2)\). While corrections are expected due to the finite extent of the wavefunctions, these corrections amount, for the most part, to a renormalization of \(C_{\text{BLG}}\), upon which our results do not sensitively depend.

The quantities of interest obey the general electrostatic
charge field relations

\[ C^0_t(v_1 - v_1) = \frac{1}{2} (n_1 - n_1 - n_2 - n_2), \quad (17) \]
\[ C^{0\text{BLG}}_t(v_1 - v_2) = \frac{1}{2} (n_1 + n_1 - n_2 - n_2), \quad (18) \]
\[ C_0^b(v_2 - v_b) = \frac{1}{2} (n_1 + n_1 + n_2 - n_2), \quad (19) \]
\[ n_1 + n_1 + n_2 + n_2 = 0. \quad (20) \]

To complete the system of equations for charge densities and potentials, a set of constitutive relations for BLG must be used. These relations, which are of general form
\[ n_1 = f_1(v_1, v_2), \quad n_2 = f_2(v_1, v_2), \]
will be calculated in subsequent sections.

Capacitance measurements are done in the finite frequency regime, by applying a small AC bias (on top of the DC bias used to control density and interlayer imbalance) to one terminal of the device and then recording the resulting change in charge density on a second terminal. Choice of terminals distinguishes top (back) gate capacitance, \( C_{t(b)} \), from penetration field capacitance, \( C_p \).

\[ C_{t(b)} = -\left. \frac{\delta n_1 + \delta n_2}{\delta v_{t(b)}} \right|_{\delta n_{t(b)}=0} \quad \text{and} \quad C_p = -\left. \frac{\delta n_b}{\delta v_b} \right|_{\delta n_b=0}. \quad (21) \]

After eliminating \( n_1 \) and \( n_b \) from Eqs. (17)-(20) by expressing them in terms of other variables, \( n_1 = C^0_t(v_1 - v_1), \quad n_b = C^0_b(v_b - v_2) \), the remaining two equations are linearized with the help of the matrix of inter- and intralayer compressibilities

\[ \hat{\nu} = -\begin{pmatrix} \frac{\partial C_{t(b)}}{\partial v_1} & \frac{\partial C_{t(b)}}{\partial v_2} \\ \frac{\partial C_b}{\partial v_1} & \frac{\partial C_b}{\partial v_2} \end{pmatrix}, \quad \left( \begin{array}{c} \delta n_1 \\ \delta n_2 \end{array} \right) = -\hat{\nu} \left( \begin{array}{c} \delta v_1 \\ \delta v_2 \end{array} \right). \quad (22) \]

This yields

\[ \left[ \hat{\nu} + \hat{C} \right] \left( \begin{array}{c} \delta v_1 \\ \delta v_2 \end{array} \right) = \left( \begin{array}{c} C^0_t \delta v_n \\ C^0_b \delta v_b \end{array} \right) \quad (23) \]

where \( \hat{C} \) is a matrix of geometric capacitances,

\[ \hat{C} = \begin{pmatrix} C^{\text{BLG}}_t + C^0_t & -C^0_{\text{BLG}} \\ -C^0_{\text{BLG}} & C^0_b + C^0_b \end{pmatrix}. \quad (24) \]

These expressions account for both the geometric and ‘intrinsic’ capacitance of BLG.

Solving for \( \delta v_1, \delta v_2 \), we find the charges induced on each layer by the gate potentials:

\[ \left( \begin{array}{c} \delta n_1 \\ \delta n_2 \end{array} \right) = \left[ 1 - \hat{C} (\hat{\nu} + \hat{C})^{-1} \right] \left( \begin{array}{c} C^0_t \delta v_n \\ C^0_b \delta v_b \end{array} \right). \quad (25) \]

Here the first term describes the geometric capacitance, which would be the only contribution if the electronic system in BLG was infinitely compressible, \( \hat{\nu} \to \infty \). The term proportional to \(-\hat{C}(\hat{\nu} + \hat{C})^{-1}\) describes the quantum capacitance contribution. Combining equation (25) with the relations for \( n_1 \) and \( n_b \), all three capacitance observables can be calculated:

\[ C_t = C^0_t \left( 1 - \frac{\det(\hat{C}) - C^0_t \nu_{21} + C^0_b \nu_{22}}{\det(\hat{\nu} + \hat{C})} \right) \quad (26) \]
\[ C_b = C^0_b \left( 1 - \frac{\det(\hat{C}) - C^0_t \nu_{12} + C^0_b \nu_{11}}{\det(\hat{\nu} + \hat{C})} \right) \quad (27) \]
\[ C_p = \frac{C^0_b - C^0_t}{\det(\hat{\nu} + \hat{C})} (C^0_{\text{BLG}} - \nu_{21}) \quad (28) \]

These quantities implicitly depend on the gate potentials through the compressibility matrix \( \nu_{ij} \).

Notably, different capacitance observables depend on different combinations of the compressibility matrix elements, and obey different symmetries. The penetration field capacitance \( C_p \) is dominated by the off diagonal component of the (necessarily symmetric) compressibility matrix. As a result, for a symmetric device (\( C^b_b = C^b_t \)) it is invariant under interchanging layers 1 and 2 and therefore does not exhibit the NLCE effect. In contrast, the expressions for \( C_b \) and \( C_t \) are not \( 1 \leftrightarrow 2 \) invariant. In particular, the last term in the expression for \( C_t \), proportional to \( \nu_{22} \), changes to \( \nu_{11} \) upon layer permutation. As shown in the previous section, in the presence of a layer imbalance these two quantities are not the same, leading to the observed NLCE observed in Ref.12.

In a device in which all capacitances can be measured, combinations of the measured quantities can be combined to probe the charge-flavor response. For the simplest case of a symmetric gate configuration (\( C^b_b = C^b_t \)),

\[ \frac{C_t - C_b}{C_p} = \frac{4 \nu_{++}}{4C^0_{BLG} + \nu_{--} - \nu_{++}}. \quad (29) \]
Because this quantity is proportional to $\nu_{-+}$, it can be used to probe both gate-induced and spontaneous layer polarization, allowing direct experimental measurement—somewhat analogous to Knight Shift measurements for spin—of the ground state layer polarization.

V. THE EFFECT OF DISORDER

In the devices used for capacitance measurements in Refs.12,11, graphene flakes were supported by a silica substrate. The carrier mobility in such devices was of order 1,000 cm$^2$/V sec. For such low-mobility devices, taking into account the effect of disorder is crucial for developing a sensible model of the experimental data. Full quantitative description of experiments requires including realistic disorder, which is likely long range$^{33-35}$, along with the effects of electronic correlations$^{36}$ which can give quantitative corrections to the electronic compressibility. However, the only features of the data are captured by a simpler short range disorder model$^{37}$, which involves delta-function impurities localized on carbon sites:

$$H = \sum_p \psi_p^\dagger H_0 \psi_p + \sum_x u(x) \psi_x^\dagger \psi_x,$$  \hspace{1cm} (30)

with potential $u(x) = \sum_i U \delta(x - x_i)$ taking values $U$ on the carbon sites occupied by impurities, and zero elsewhere. The impurities are assumed to be distributed randomly with concentration $n$.

The problem (30) can be analyzed using a self-consistent T-matrix approximation (SCTA). The SCTA approach provides a somewhat more general approach than the self-consistent Born approximation, and is reduced to the latter for weak disorder.

We evaluate the DOS and the total energy by employing disorder-averaged Greens functions expressed through the layer-indexed disorder-averaged self-energies $\Sigma_i$

$$G(\varepsilon, p) = \left[ \varepsilon - v_1 - \Sigma_1 - t_p^* \varepsilon - v_2 - \Sigma_2 \right]^{-1},$$  \hspace{1cm} (31)

where $t_p$ is the kinetic energy operator$^{27-29}$, $t_k \propto (1 + e^{-i k 1} + e^{-i k 2})^2$. An infinitesimal imaginary part $\pm i \delta$ should be added to $\varepsilon$ to obtain the retarded and advanced Greens functions.

The self-energy is approximated by the average values of the T-matrix, evaluated separately for the sites on layers 1 and 2,

$$\Sigma_1(\varepsilon) = \bar{n} \langle T_1(\varepsilon) \rangle, \quad \Sigma_2(\varepsilon) = \bar{n} \langle T_2(\varepsilon) \rangle.$$  \hspace{1cm} (32)

Here $\bar{n} = n \rho_0$ is the adatom density with $\rho_0 = 2/3\sqrt{3}a^2$ the density of type 1 sites. The quantities $T_{1,2}(\varepsilon)$, written as a $2 \times 2$ matrix, are given by

$$\left[ \begin{array}{cc} T_{11} & 0 \\ 0 & T_{22} \end{array} \right] = \frac{\tilde{U}}{1 - U g}, \quad g = \int \frac{d^2 p}{(2\pi)^2} G(\varepsilon, p),$$  \hspace{1cm} (33)

where $\tilde{U} = U/\rho_0$. For realistic values of $v_1$ and $v_2$ the integral of the Greens function over the Brillouin zone is dominated by the regions near $K$ and $K'$; approximating $t_p \approx (p_x \pm i p_y)^2/2m$, we obtain

$$g = \frac{-i m}{2\sqrt{\varepsilon_1 \varepsilon_2}} \left[ \begin{array}{cc} \varepsilon_2 & 0 \\ 0 & \varepsilon_1 \end{array} \right], \quad \varepsilon_1(\varepsilon) = \varepsilon - v_1(\varepsilon) - \Sigma_1(\varepsilon).$$  \hspace{1cm} (34)

This expression is valid for $\varepsilon_1(\varepsilon)$ small compared to the bandwidth. Combining this result with Eq.(32), we obtain two coupled equations for $\varepsilon_1, \varepsilon_2$:

$$\varepsilon_1(\varepsilon) = \varepsilon - v_1 - \frac{n U}{1 + i \beta / \lambda(\varepsilon)}, \quad \varepsilon_2(\varepsilon) = \varepsilon - v_2 - \frac{n U}{1 + i \beta / \lambda(\varepsilon)},$$  \hspace{1cm} (35)

where we defined $\lambda(\varepsilon) = \sqrt{\varepsilon_1(\varepsilon) \varepsilon_2(\varepsilon)}$ and $\beta = m \tilde{U}/2$. Solving these equations for $\varepsilon_1, \varepsilon_2$ as a function of $\varepsilon$, we find the Greens function (31) and use it to calculate the density of states,

$$\rho(\varepsilon) = \frac{1}{\pi} \text{Im} \int G(\varepsilon + i 0, p) \frac{d^2 p}{(2\pi)^2} = \frac{m}{\pi} \left[ \lambda^{-1}(\varepsilon) \begin{array}{cc} 0 \\ \lambda(\varepsilon) \end{array} \right],$$  \hspace{1cm} (36)

where the integral is identical to the one in Eq.(34). A factor of two was inserted after integration to account for spin degeneracy.

The density of states is expressed through the quantity $\lambda(\varepsilon)$. Taking the ratio of the self-consistent equations for $\varepsilon_1$ and $\varepsilon_2$, Eq.(35), we obtain a single equation for
In the absence of disorder, \( \gamma \), the quantities entering in \( \varepsilon_0 = 50 \text{meV} \) and the cutoff \( \Lambda = 5 \text{eV} \). Geometric parameters are chosen to match experiment reported in Ref.[12]. \( C^0_C = 30 \). \( C_b = 120 \mu \text{F/}\mu \text{m}^2 \). Color scheme corresponds to varying values of \( \gamma \) as in Fig. 4.

The quantity \( \lambda \). Focusing on the case of weak disorder potential and expanding in \( U \), we arrive at

\[
\lambda^2 = \frac{\varepsilon - v_1 + i\gamma/\lambda}{\varepsilon - v_2 + i\gamma}, \quad \gamma = \frac{mU^2}{2\varepsilon_0^2 n},
\]

(37)

where the terms linear in \( U \) have been incorporated in the quantities \( v_1, v_2 \). Once \( \lambda(\varepsilon) \) is found from Eq.(37), it can be plugged into Eq.(36) to obtain partial densities of states on each of the layers (see Fig.3),

\[
\rho_1(\varepsilon) = \frac{i\nu_0}{2} \text{Re} \lambda^{-1}, \quad \rho_2(\varepsilon) = \frac{i\nu_0}{2} \text{Re} \lambda.
\]

(38)

In the absence of disorder, \( \gamma = 0 \), we have \( \lambda = \sqrt{(\varepsilon - v_1)/(\varepsilon - v_2)} \), which gives van Hove singularities of an inverse square root form at the band edges \( \varepsilon = v_1, v_2 \) as found in section I. In the presence of disorder, these singularities are washed out to varying degrees. As shown in Fig.4, this washing out proceeds by both reducing the height of the vHS peak and closing the gap. Crucially, the ‘off’-layer density of states at the energy of the ‘on’ layer vHS peak increases with disorder. This has the effect of increasing the screening effect of the ‘off’ layer when it lies closer to the gate used to measure capacitance, enhancing the NLCE effect for disordered samples.

To calculate experimental capacitances, Eqs. (27)-(28), the partial densities of states are integrated numerically with respect to energy and then redifferentiated with respect to the appropriate energy variable, \( v_1 \) or \( v_2 \). In Figure 5, the results for both top gate and penetration field capacitance for a device with electrostatic parameters resembling those in Ref.12 are plotted. The asymmetry of top gate capacitance survives disorder averaging, and indeed is enhanced. For intermediate values of disorder, electrons and holes display qualitatively different behavior: the non-monotonic vHS feature survives for holes but is completely obliterated for electrons, as observed in Ref.12.

VI. CONCLUSIONS

As we argue above, electrostatic capacitance measurements offer a unique which-layer probe for BLG. The sensitivity to the interlayer imbalance arises despite the fact that the layers are not contacted separately: the relative proximity of the layers to the top- and bottom-gates, combined with the interlayer screening, allows capacitance measurements to access layer specific quantities. Gate capacitance measurements preferentially probe the nearer layer, leading to the NLCE effect as the near layer screens the far layer. Consequently, in the presence of a layer imbalance, top- and bottom- gate capacitance measurements will be different. This difference is the signature of layer polarization, allowing its unambiguous experimental determination.

Our analysis provides an explanation of recent top gate capacitance experiments on dual gate bilayer graphene structures[11,12]. Since the degeneracy of the band crossing in the BLG spectrum at the \( K \) and \( K' \) points is linked to inversion symmetry, the gate-induced density imbalance and the opening of a band gap go hand in hand[27-29]. As we have shown, this imbalance can be probed directly through NLCE measurements; to our knowledge, the NLCE-type asymmetry observed in Ref.12 is the first direct experimental evidence of layer imbalance in BLG.

The possibility of probing layer polarization directly through capacitance measurements has implications beyond the study of gate-induced gap opening. Recently, experimental sample quality has improved to the point of allowing the observation of a multitude of novel features likely associated with electronic correlations[26,38-41]. A large number of possible broken symmetry states, arising in the presence and in the absence of magnetic field, have been explored in the theoretical literature[17-25], including several mutually exclusive scenarios for the ordering at low densities and small electric and magnetic fields. The main open questions pertaining to these states have to do with identifying broken symmetries and determining the exact structure of the order parameter and excitations. Future NLCE measurements, by offering a direct method for determination of the layer polarization, will help to narrow down the possibilities for these new states.

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